


<b>Search Notes</b>  	<b>Application/Control No.</b>  10765205	<b>Applicant(s)/Patent Under Reexamination</b>  HE ET AL.
	<b>Examiner</b>  Hoang, Hieu T	<b>Art Unit</b>  2152

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
709	230, 236, 238, 227, 249, 250, 251, 238, 243	11/19/2007	HH

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST	11/19/2007	HH
IDS	11/19/2007	HH
NPL (Google, IETF, IEEE)	11/19/2007	HH

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>